

ISO/IEC 22092 :2002-07 (E)

Information technology_- Data interchange on 130_mm magneto-optical disk cartridges_- Capacity:
9,1_Gbytes per cartridge

Contents

Section 1 - General	1
1 Scope	1
2 Conformance	1
2.1 Optical Disk Cartridge (ODC)	1
2.2 Generating system	1
2.3 Receiving system	1
2.4 Compatibility statement	1
3 Normative reference	2
4 Terms and definitions	2
4.1 asymmetry	2
4.2 band	2
4.3 case	2
4.4 clamping zone	2
4.5 control track	2
4.6 Cyclic Redundancy Check (CRC)	2
4.7 defect management	2
4.8 disk reference plane	2
4.9 emulation	2
4.10 entrance surface	2
4.11 Error Correction Code (ECC)	2
4.12 format	2
4.13 hub	2
4.14 interleaving	2
4.15 Kerr rotation	3
4.16 land and groove	3
4.17 logical track	3
4.18 mark	3
4.19 mark edge	3
4.20 mark edge recording	3
4.21 optical disk	3
4.22 optical disk cartridge (ODC)	3
4.23 physical track	3
4.24 polarization	3
4.25 pre-recorded mark	3
4.26 read power	3
4.27 recording layer	3
4.28 recording track	3
4.29 Reed-Solomon code	3
4.30 space	3
4.31 spindle	4
4.32 substrate	4
4.33 track pitch	4
4.34 write-inhibit hole	4
4.35 write-once functionality	4
4.36 zone	4

5	Conventions and notations	4
5.1	Representation of numbers	4
5.2	Names	4
6	List of acronyms	4
7	General description of the optical disk cartridge	5
8	General requirements	5
8.1	Environments	5
8.1.1	Test environment	5
8.1.2	Operating environment	5
8.1.3	Storage environment	6
8.1.4	Transportation	6
8.2	Temperature shock	6
8.3	Safety requirements	6
8.4	Flammability	6
9	Reference Drive	6
9.1	Optical system	7
9.2	Optical beam	8
9.3	Read channels	8
9.4	Tracking	8
9.5	Rotation of the disk	8
Section 2 - Mechanical and physical characteristics		9
10	Dimensional and physical characteristics of the case	9
10.1	General description of the case	9
10.2	Relationship of Sides A and B	9
10.3	Reference axes and case reference planes	9
10.4	Case drawings	9
10.5	Dimensions of the case	9
10.5.1	Overall dimensions	9
10.5.2	Location hole	10
10.5.3	Alignment hole	10
10.5.4	Surfaces on Reference Planes P	11
10.5.5	Insertion slots and detent features	12
10.5.6	Gripper slots	12
10.5.7	Write-inhibit holes	12
10.5.8	Media sensor holes	13
10.5.9	Head and motor window	14
10.5.10	Shutter	14
10.5.11	Slot for shutter opener	14
10.5.12	Shutter sensor notch	15
10.5.13	User label areas	15
10.6	Mechanical characteristics	16
10.6.1	Materials	16
10.6.2	Mass	16
10.6.3	Edge distortion	16
10.6.4	Compliance	16
10.6.5	Shutter opening force	16
10.7	Drop test	16
11	Dimensional, mechanical and physical characteristics of the disk	16
11.1	General description of the disk	16
11.2	Reference axis and plane of the disk	16
11.3	Dimensions of the disk	16
11.3.1	Hub dimension	17
11.4	Mechanical characteristics	18

11.4.1	Material	18
11.4.2	Mass	18
11.4.3	Moment of inertia	18
11.4.4	Imbalance	18
11.4.5	Axial deflection	18
11.4.6	Axial acceleration	18
11.4.7	Radial runout	19
11.4.8	Radial acceleration	19
11.4.9	Tilt	19
11.5	Optical characteristics	19
11.5.1	Index of refraction	19
11.5.2	Thickness	19
11.5.3	Birefringence	19
11.5.4	Vertical Birefringence	19
11.5.5	Reflectance	20
12	Interface between cartridge and drive	20
12.1	Clamping method	20
12.2	Clamping force	20
12.3	Capture cylinder	20
12.4	Disk position in the operating condition	21
Section 3 - Format of information		35
13	Track and Header geometry	35
13.1	Track and Header shape	35
13.2	Direction of track spiral	36
13.3	Track pitch	36
13.4	Logical track number	36
14	Track format	36
14.1	Physical track layout	36
14.2	Logical track layout	39
14.3	Radial alignment	39
14.4	Sector number	39
15	Sector format	39
15.1	Sector layout	39
15.2	Sector Mark	40
15.3	VFO fields	41
15.4	Address Mark (AM)	41
15.5	ID fields	41
15.6	Postamble (PA ₁)	42
15.7	Transition Area (TA ₁)	42
15.8	Gap	42
15.9	Auto Laser Power Control (ALPC)	42
15.10	Sync	42
15.11	Data field	43
15.11.1	User data bytes	43
15.11.2	CRC and ECC bytes	43
15.11.3	Bytes for Sector Written Flag (SWF)	43
15.11.4	Resync bytes	43
15.12	Postamble field (PA ₂)	43
15.13	Buffer field	43
15.14	Transition Area (TA ₂)	43
16	Recording code	44
17	Formatted Zone	45
17.1	General description of the Formatted Zone	45

17.2	Division of the Formatted Zone	45
17.2.1	Lead-in Zone	46
17.2.2	Manufacturer Zones	46
17.2.3	User Zone	48
17.2.4	Reflective Zone	48
17.2.5	Control Track Zones	48
17.3	Control Track PEP Zone	48
17.3.1	Recording in the PEP Zone	48
17.3.2	Format of the tracks of the PEP Zone	49
17.4	Control Track SFP Zones	52
17.4.1	Duplicate of the PEP information	53
17.4.2	Media information	53
17.4.3	System Information	54
18	Layout of the User Zone	56
18.1	General description of the User Zone	56
18.2	Divisions of the User Zone	56
18.3	User Area	56
18.4	Defect Management Areas (DMAs)	63
18.5	Disk Definition Structure (DDS)	64
18.6	Rewritable Zone	66
18.6.1	Location	67
18.6.2	Partitioning	67
18.7	Write Once Zone	67
18.7.1	Location	67
18.7.2	Partitioning	67
19	Defect Management in the Rewritable and Write Once Zones	67
19.1	Initialization of the disk	67
19.2	Certification	67
19.2.1	Slipping Algorithm	67
19.2.2	Linear Replacement Algorithm	68
19.3	Disks not certified	68
19.4	Write procedure	68
19.5	Primary Defect List (PDL)	68
19.6	Secondary Defect List (SDL)	69
Section 4 - Characteristics of embossed information		70
20	Method of testing	70
20.1	Environment	70
20.2	Use of the Reference Drive	70
20.2.1	Optics and mechanics	70
20.2.2	Read power	70
20.2.3	Read channels	71
20.2.4	Tracking	71
20.3	Definition of signals	71
21	Signal from grooves	72
21.1	Ratio of Groove to Land	72
21.2	Push-pull signal	72
21.3	Divided push-pull signal	73
21.4	Track location	73
22	Signals from Headers	73
22.1	Sector Mark Signals	73
22.2	VFO signals	73
22.3	Address Mark, ID and PA signals	74
22.4	Timing jitter	74
22.5	Asymmetry	74

23	Signals from Control Track PEP marks	74
Section 5 - Characteristics of the recording layer		75
24	Method of testing	75
24.1	Environment	75
24.2	Reference Drive	75
24.2.1	Optics and mechanics	75
24.2.2	Read power	75
24.2.3	Read Channel	75
24.2.4	Tracking	76
24.2.5	Signal detection for testing purposes	76
24.3	Write conditions	76
24.3.1	Write pulse and power	76
24.3.2	Write magnetic field	76
24.3.3	Pulse power determination	76
24.3.4	Media power sensitivity	77
24.4	Erase conditions	77
24.4.1	Erase power	77
24.4.2	Erase magnetic field	77
24.5	Definition of signals	77
25	Magneto-optical characteristics	77
25.1	Figure of merit for magneto-optical signal	77
25.2	Imbalance of magneto-optical signal	78
26	Write characteristics	78
26.1	Resolution	78
26.2	Narrow-band signal-to-noise ratio	78
26.3	Cross-talk ratio	79
26.3.1	Rewritable track test method	79
26.4	Timing Jitter	79
26.5	Media thermal interaction	79
27	Erase power determination	80
Section 6 - Characteristics of user data		80
28	Method of testing	80
28.1	Environment	80
28.2	Reference Drive	80
28.2.1	Optics and mechanics	80
28.2.2	Read power	80
28.2.3	Read Channel	81
28.2.4	Mark Quality	81
28.2.5	Channel bit clock	81
28.2.6	Binary-to-digital converters	81
28.2.7	Error correction	81
28.2.8	Tracking	81
29	Minimum quality of a sector	81
29.1	Headers	81
29.1.1	Sector Mark	81
29.1.2	ID fields	81
29.2	User-written data	82
29.2.1	Recording field	82
29.2.2	Byte errors	82
29.2.3	Asymmetry	82
29.2.4	Timing jitter	82
30	Data interchange requirements	82

30.1	Tracking	82
30.2	User-written data	82
30.3	Quality of disk	82
Annexes		
A	Air cleanliness class 100 000	83
B	Edge distortion test	84
C	Compliance test	86
D	Test method for measuring the adsorbent force of the hub	88
E	CRC for ID fields	90
F	Interleave, CRC, ECC, Resync for the data field	91
G	Determination of Resync pattern	97
H	Read Channel for measuring jitter	102
J	Timing jitter measuring procedure	103
K	Definition of write pulse shape	104
L	Measurement of figure of merit	105
M	Implementation Independent Mark Quality Determination (IIMQD) for the interchange of recorded media	106
N	Requirements for interchange	108
P	Measurement implementation for Cross-track signal	110
Q	Asymmetry measuring definition	111
R	Office environment	113
S	Derivation of the operating climatic environment	114
T	Transportation	119
U	Sector retirement guidelines	120
V	Track deviation measurement	121
W	Values to be implemented in existing and future standards	125
X	Measurement of the vertical birefringence of the substrate	126
Y	Guidelines for the use of Type WO ODCs	128
Z	Laser power calibration for evaluation of media power sensitivity	129
AA	512-byte, 1 024-byte Sector Emulation	133